

MOSPOWER

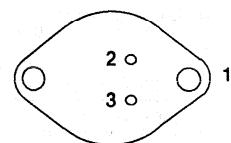
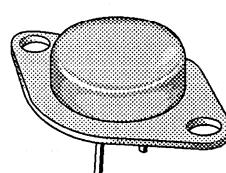
SMM60N06 SMM60N05

N-Channel Enhancement Mode Transistors

PRODUCT SUMMARY

PART NUMBER	V _{(BR)DSS} (VOLTS)	r _{DS(on)} (OHMS)	I _D (AMPS)
SMM60N06	60	0.023	60
SMM60N05	50	0.023	60

BOTTOM VIEW



TO-204AE (TO-3)

- 1 DRAIN (CASE)
- 2 GATE
- 3 SOURCE

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

PARAMETERS/TEST CONDITIONS	Symbol	SMM		Units
		60N06	60N05	
Drain-Source Voltage	V _{DS}	60	50	V
Gate-Source Voltage	V _{GS}	±40	±40	
Continuous Drain Current	I _D	60	60	A
T _C = 100°C		36	36	
Pulsed Drain Current ¹	I _{DM}	240	240	
Power Dissipation	P _D	150	150	W
T _C = 100°C		60	60	
Operating Junction & Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C
Lead Temperature (1/16" from case for 10 secs.)	T _L	300		

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THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	Symbol	Typ.	Max.	Units
Junction-to-Case	R _{thJC}	-	0.83	K/W
Junction-to-Ambient	R _{thJA}	-	30	
Case-to-Sink	R _{thCS}	0.1	-	

¹Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, figure 11)

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS/TEST CONDITIONS		Symbol	Min.	Typ.	Max.	Units
Drain-Source Breakdown Voltage $V_{GS} = 0$, $I_D = 250 \mu\text{A}$	SMM60N06 SMM60N05	$V_{(\text{BR})\text{DSS}}$	60 50	65 55	- -	V
Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 1000 \mu\text{A}$		$V_{GS(\text{th})}$	2.0	-	4.0	
Gate-Body Leakage $V_{DS} = 0$, $V_{GS} = \pm 20 \text{ V}$		I_{GSS}	-	-	100	nA
Zero Gate Voltage Drain Current $V_{DS} = V_{(\text{BR})\text{DSS}}$, $V_{GS} = 0$		I_{DSS}	-	-	250	μA
Zero Gate Voltage Drain Current $V_{DS} = 0.8 \times V_{(\text{BR})\text{DSS}}$, $V_{GS} = 0$, $T_J = 125^\circ\text{C}$		I_{DSS}	-	-	1000	
On-State Drain Current ² $V_{DS} = 2.0 \text{ V}$, $V_{GS} = 10 \text{ V}$		$I_{D(\text{on})}$	60	-	-	A
Drain-Source On-State Resistance ² $V_{GS} = 10 \text{ V}$, $I_D = 30 \text{ A}$		$r_{DS(\text{on})}$	-	0.019	0.023	Ω
Drain-Source On-State Resistance ² $V_{GS} = 10 \text{ V}$, $I_D = 30 \text{ A}$, $T_J = 125^\circ\text{C}$		$r_{DS(\text{on})}$	-	0.025	0.032	
Forward Transconductance ² $V_{DS} = 25 \text{ V}$, $I_D = 30 \text{ A}$		g_{fs}	15	18	-	S(Ω)
Input Capacitance	$V_{GS} = 0$ $V_{DS} = 25 \text{ V}$ $f = 1 \text{ MHz}$	C_{iss}	-	2900	3500	pF
Output Capacitance		C_{oss}	-	1500	1600	
Reverse Transfer Capacitance		C_{rss}	-	500	600	
Total Gate Charge	$V_{DS} = 0.5 \times V_{(\text{BR})\text{DSS}}$, $V_{GS} = 10 \text{ V}$, $I_D = 60 \text{ A}$ (Gate charge is essentially independent of operating temperature)	Q_g	-	65	75	nC
Gate-Source Charge		Q_{gs}	-	15	-	
Gate-Drain Charge		Q_{gd}	-	35	-	
Turn-On Delay Time	$V_{DD} = 30 \text{ V}$, $R_L = 1.0 \Omega$ $I_D = 30 \text{ A}$, $V_{GEN} = 10 \text{ V}$ $R_G = 2.5 \Omega$ (Switching time is essentially independent of operating temperature)	$t_{d(\text{on})}$	-	20	40	ns
Rise Time		t_r	-	25	50	
Turn-Off Delay Time		$t_{d(\text{off})}$	-	30	60	
Fall Time		t_f	-	20	40	

SOURCE-DRAIN DIODE RATINGS & CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS/TEST CONDITIONS		Symbol	Min.	Typ.	Max.	Units
Continuous Current		I_S	-	-	60	A
Pulsed Current ¹		I_{SM}	-	-	240	
Forward Voltage ² $I_F = I_S$, $V_{GS} = 0$		V_{SD}	-	-	2.5	V
Reverse Recovery Time $I_F = I_S$, $dI_F/dt = 100 \text{ A}/\mu\text{s}$		t_{rr}	-	75	100	ns
Reverse Recovered Charge $I_F = I_S$, $dI_F/dt = 100 \text{ A}/\mu\text{s}$		Q_{rr}	-	0.19	-	μC

¹ Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, figure 11)² Pulse test: Pulse width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$



Siliconix
incorporated

SMM60N06, SMM60N05

PERFORMANCE CURVES (25°C Unless otherwise noted)

FIGURE 1: Typical Output Characteristics

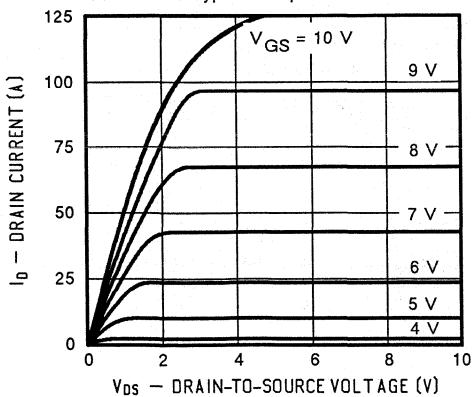


FIGURE 2: Typical Transfer Characteristics

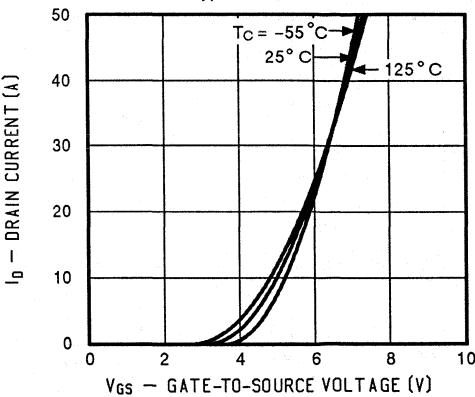


FIGURE 3: Typical Transconductance

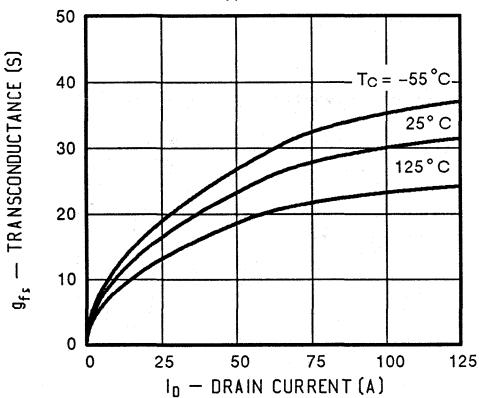


FIGURE 4: Typical On-Resistance

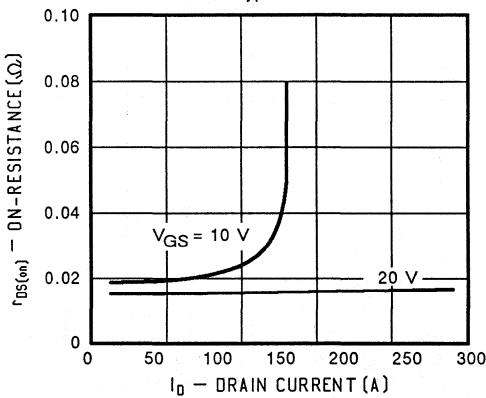


FIGURE 5: Typical Capacitance

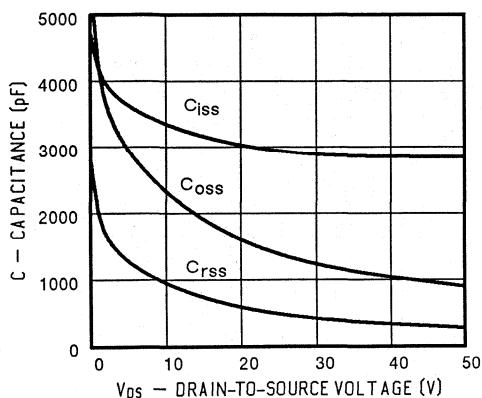
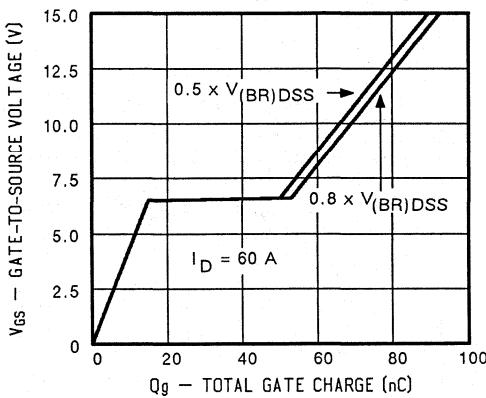


FIGURE 6: Typical Gate Charge



PERFORMANCE CURVES (25°C Unless otherwise noted)

FIGURE 7: On-Resistance vs. Junction Temperature

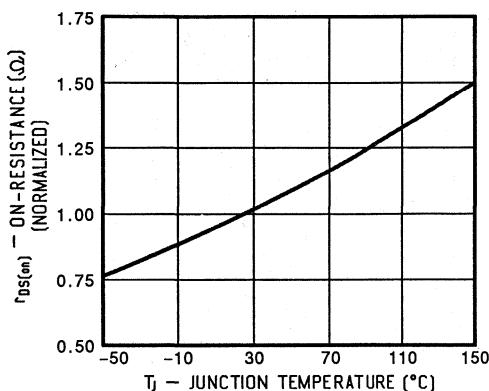


FIGURE 8: Typical Source-Drain Diode Forward Voltage

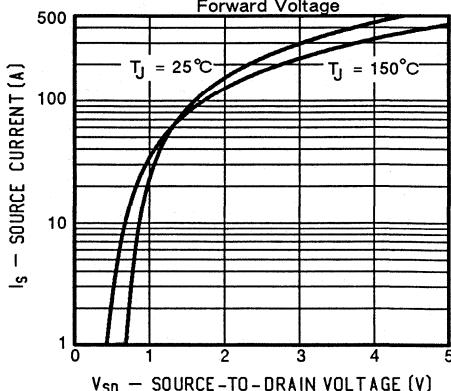


FIGURE 9: Maximum Drain Current vs. Case Temperature

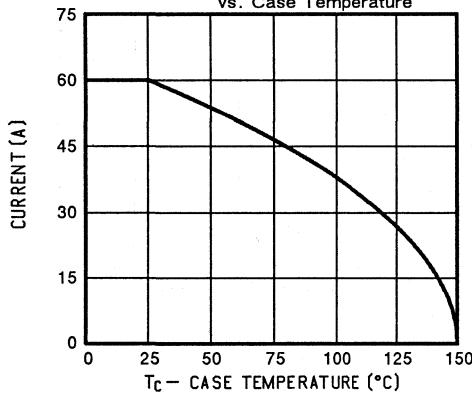
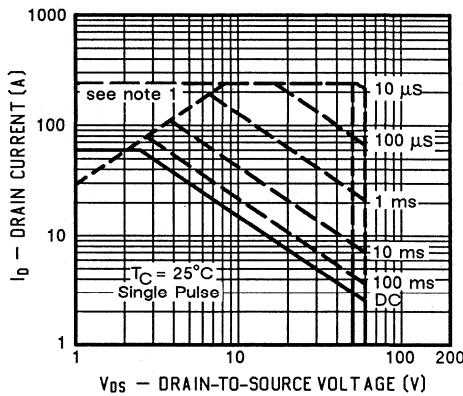


FIGURE 10: Safe Operating Area



¹Operation in this area may be limited by $r_{DS(on)}$

FIGURE 11: Normalized Effective Transient Thermal Impedance, Junction-to-Case

